Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/785,182	WANG ET AL.
Examiner	Art Unit
Anabel M. Ton	2875

	SEAR	CHED	
Class	Subclass	Date	Examiner
362	600	12/10/2005	AT
	561		
	290		
	339		
	28		
	97		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	}			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			